

BT169H

Thyristor, logic level, high voltage

Rev. 01 — 31 March 2008

Product data sheet

1. Product profile

1.1 General description

Passivated sensitive gate thyristor in a SOT54 plastic package.

1.2 Features

- Very sensitive gate
- Direct interfacing to logic level ICs
- High blocking voltage
- Direct interfacing to low power gate drive circuits

1.3 Applications

- General purpose switching and phase control
- Earth leakage circuit breakers or Ground Fault Circuit Interrupters (GFCI)

1.4 Quick reference data

- $V_{RRM}, V_{DRM} \leq 800$ V
- $I_{T(RMS)} \leq 0.8$ A
- $I_{T(AV)} \leq 0.5$ A
- $I_{GT} \leq 100$ μ A
- $I_{TSM} \leq 9$ A ($t = 10$ ms)

2. Pinning information

Table 1. Pinning

Pin	Description	Simplified outline	Graphic symbol
1	anode (A)	 SOT54 (TO-92)	 A — ∇ — K G sym037
2	gate (G)		
3	cathode (K)		

3. Ordering information

Table 2. Ordering information

Type number	Package		Version
	Name	Description	
BT169H	TO-92	plastic single-ended leaded (through hole) package; 3 leads	SOT54

4. Limiting values

Table 3. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V_{DRM}	repetitive peak off-state voltage		-	800	V
V_{RRM}	repetitive peak reverse voltage		-	800	V
$I_{T(AV)}$	average on-state current	half sine wave; $T_{lead} \leq 83\text{ °C}$; see Figure 1	-	0.5	A
$I_{T(RMS)}$	RMS on-state current	all conduction angles; see Figure 4 and 5	-	0.8	A
I_{TSM}	non-repetitive peak on-state current	half sine wave; $T_j = 25\text{ °C}$ prior to surge; see Figure 2 and 3			
		$t = 10\text{ ms}$	-	9	A
		$t = 8.3\text{ ms}$	-	10	A
I^2t	I^2t for fusing	$t_p = 10\text{ ms}$	-	0.41	A^2s
di_T/dt	rate of rise of on-state current	$I_{TM} = 2\text{ A}$; $I_G = 10\text{ mA}$; $di_G/dt = 100\text{ mA}/\mu s$	-	50	$A/\mu s$
I_{GM}	peak gate current		-	1	A
V_{RGM}	peak reverse gate voltage		-	5	V
P_{GM}	peak gate power		-	2	W
$P_{G(AV)}$	average gate power	over any 20 ms period	-	0.1	W
T_{stg}	storage temperature		-40	+150	$^{\circ}C$
T_j	junction temperature		-	125	$^{\circ}C$

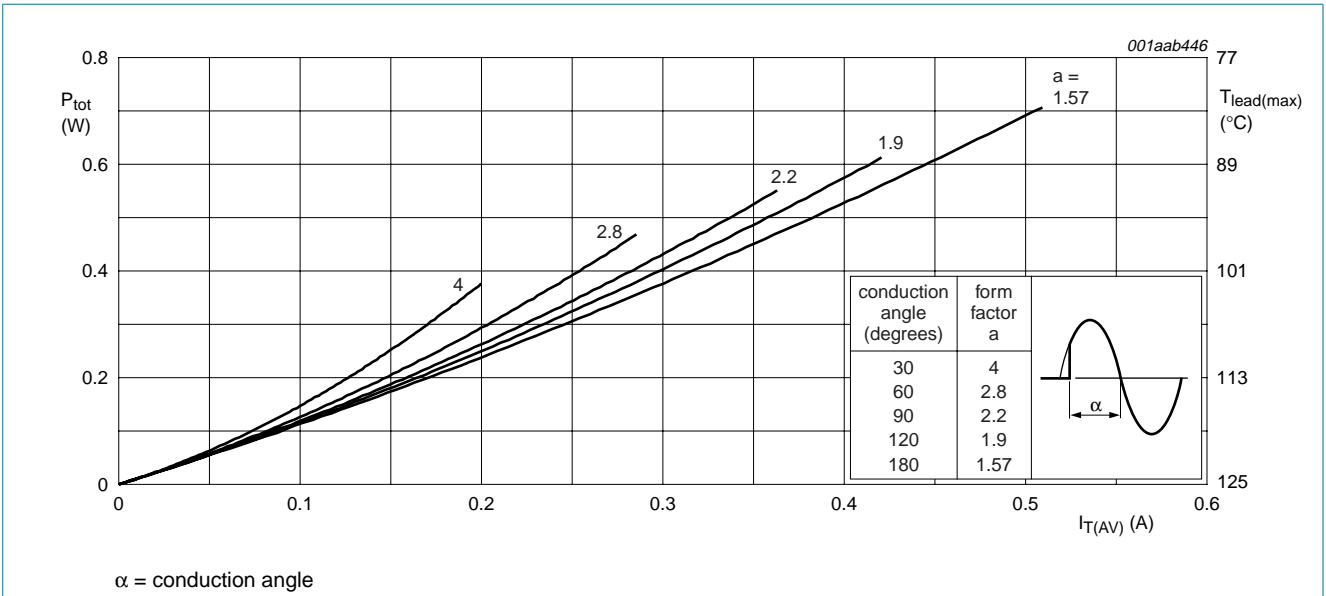


Fig 1. Total power dissipation as a function of average on-state current; maximum values

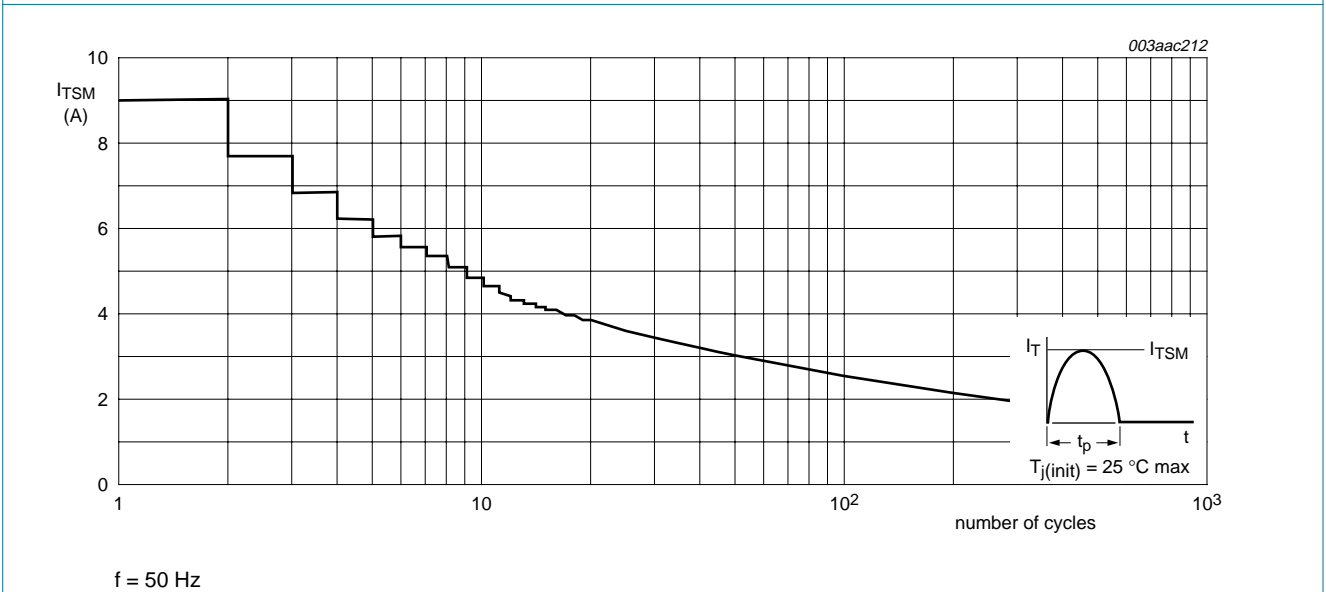


Fig 2. Non-repetitive peak on-state current as a function of the number of sinusoidal current cycles; maximum values

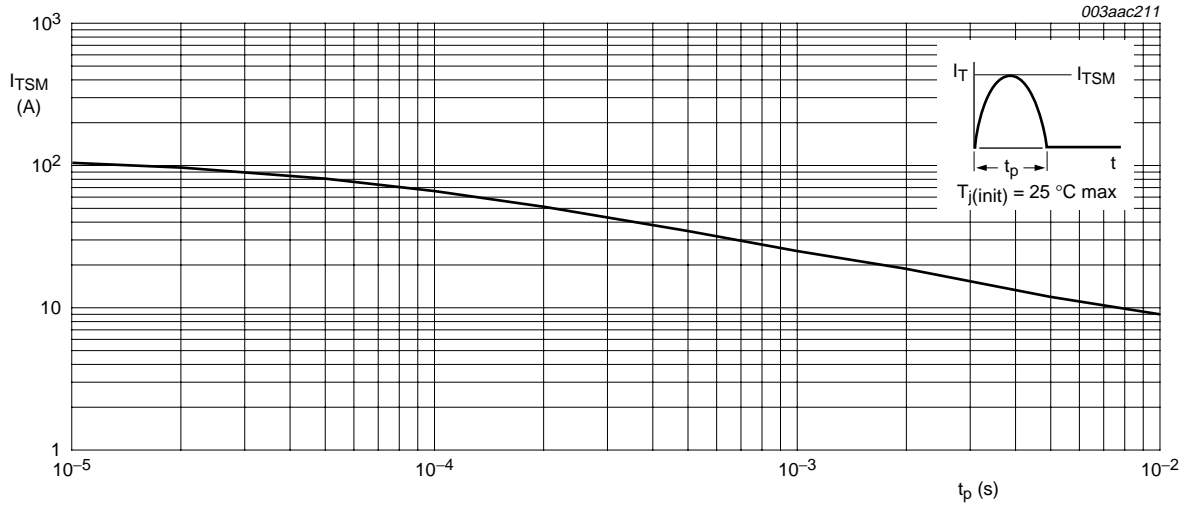
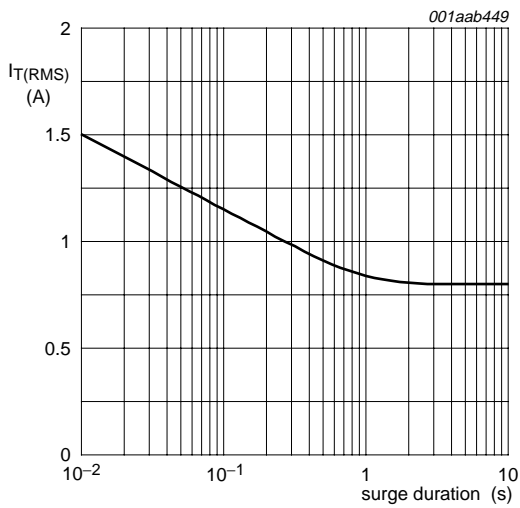
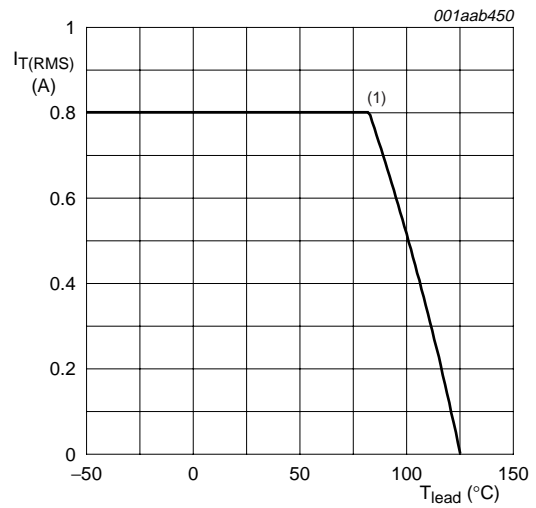


Fig 3. Non-repetitive peak on-state current as a function of pulse width; maximum values



$f = 50 \text{ Hz}$
 $T_{\text{lead}} = 83 \text{ }^\circ\text{C}$

Fig 4. RMS on-state current as a function of surge duration; maximum values



(1) $T_{\text{lead}} = 83 \text{ }^\circ\text{C}$

Fig 5. RMS on-state current as a function of lead temperature; maximum values

5. Thermal characteristics

Table 4. Thermal characteristics

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$R_{th(j-lead)}$	thermal resistance from junction to lead	see Figure 6	-	-	60	K/W
$R_{th(j-a)}$	thermal resistance from junction to ambient	printed circuit board mounted; lead length 4 mm	-	150	-	K/W

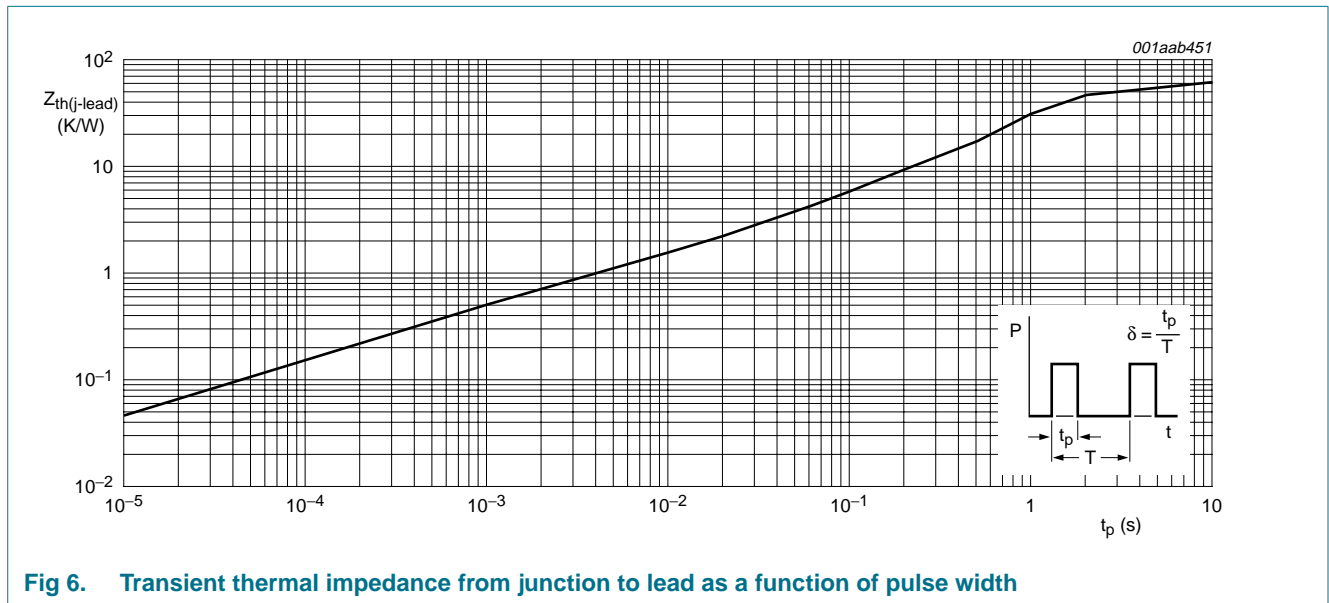


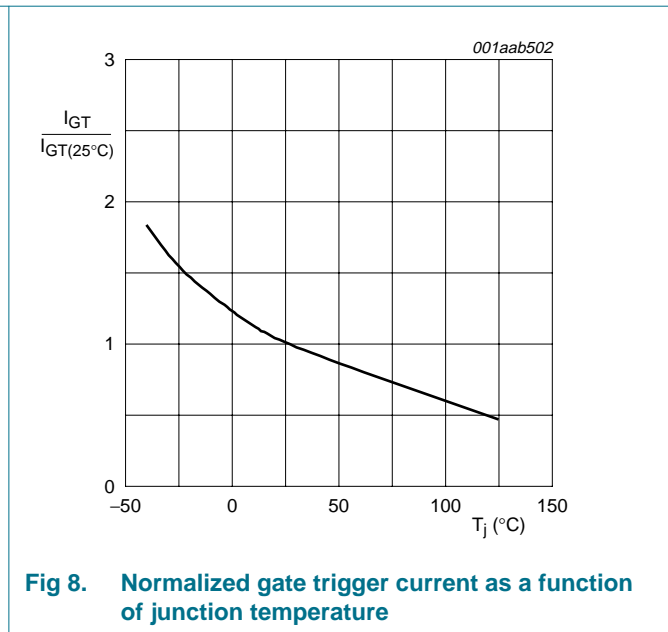
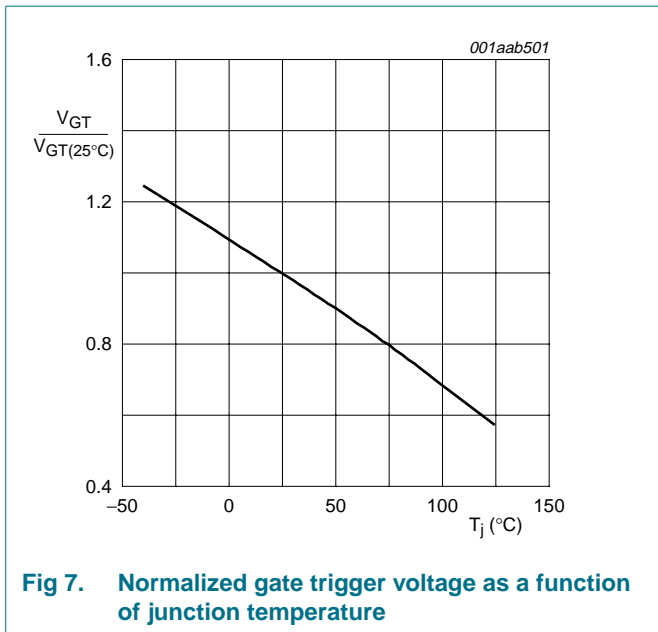
Fig 6. Transient thermal impedance from junction to lead as a function of pulse width

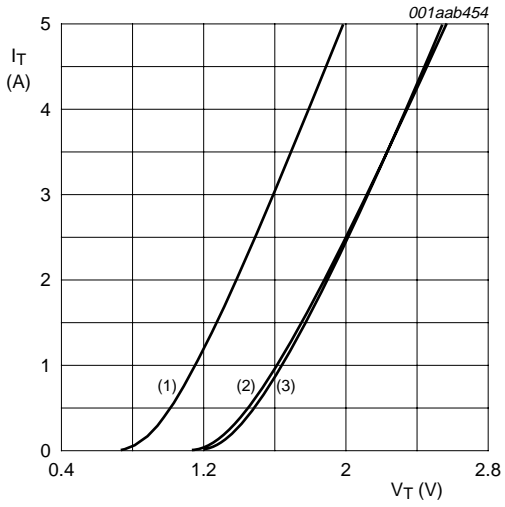
6. Characteristics

Table 5. Characteristics

$T_j = 25\text{ }^\circ\text{C}$ unless otherwise specified.

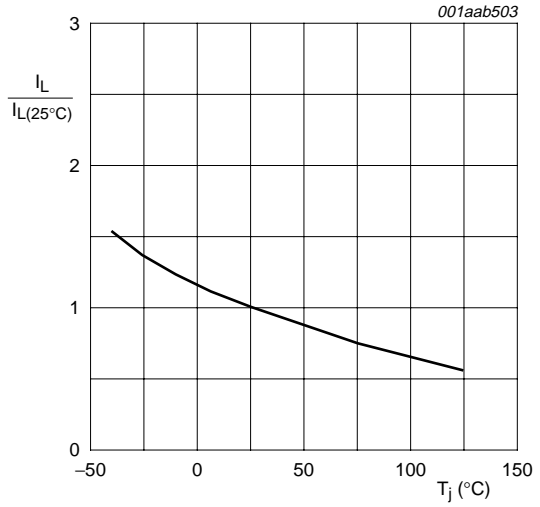
Symbol	Parameter	Conditions	Min	Typ	Max	Unit
Static characteristics						
I_{GT}	gate trigger current	$V_D = 12\text{ V}$; $I_T = 10\text{ mA}$; see Figure 8	1	50	100	μA
I_L	latching current	$V_D = 12\text{ V}$; $I_G = 0.5\text{ mA}$; $R_{GK} = 1\text{ k}\Omega$; see Figure 10	-	2	6	mA
I_H	holding current	$V_D = 12\text{ V}$; $I_G = 0.5\text{ mA}$; $R_{GK} = 1\text{ k}\Omega$; see Figure 11	-	1.5	3	mA
V_T	on-state voltage	$I_T = 1.2\text{ A}$; see Figure 9	-	1.25	1.7	V
V_{GT}	gate trigger voltage	$I_T = 10\text{ mA}$; see Figure 7				
		$V_D = 12\text{ V}$	-	0.5	0.8	V
		$V_D = V_{DRM(max)}$; $T_j = 125\text{ }^\circ\text{C}$	0.2	0.3	-	V
I_D	off-state current	$V_D = V_{DRM(max)}$; $T_j = 125\text{ }^\circ\text{C}$; $R_{GK} = 1\text{ k}\Omega$	-	0.05	0.1	mA
I_R	reverse current	$V_R = V_{RRM(max)}$; $T_j = 125\text{ }^\circ\text{C}$; $R_{GK} = 1\text{ k}\Omega$	-	0.05	0.1	mA
Dynamic characteristics						
dV_D/dt	rate of rise of off-state voltage	$V_{DM} = 0.67 \times V_{DRM(max)}$; $T_j = 125\text{ }^\circ\text{C}$; exponential waveform; see Figure 12				
		$R_{GK} = 1\text{ k}\Omega$	150	350	-	$\text{V}/\mu\text{s}$
t_{gt}	gate-controlled turn-on time	$I_{TM} = 2\text{ A}$; $V_D = V_{DRM(max)}$; $I_G = 10\text{ mA}$; $dI_G/dt = 0.1\text{ A}/\mu\text{s}$	-	2	-	μs
t_q	commutated turn-off time	$V_D = 0.67 \times V_{DRM(max)}$; $T_j = 125\text{ }^\circ\text{C}$; $I_{TM} = 1.6\text{ A}$; $V_R = 35\text{ V}$; $(dI_T/dt)_M = 30\text{ A}/\mu\text{s}$; $dV_D/dt = 2\text{ V}/\mu\text{s}$; $R_{GK} = 1\text{ k}\Omega$	-	100	-	μs





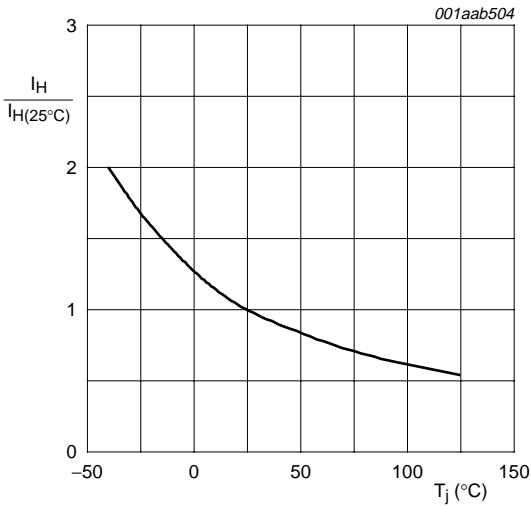
$V_o = 1.067\text{ V}$
 $R_s = 0.187\ \Omega$
 (1) $T_j = 125\text{ }^\circ\text{C}$; typical values
 (2) $T_j = 125\text{ }^\circ\text{C}$; maximum values
 (3) $T_j = 25\text{ }^\circ\text{C}$; maximum values

Fig 9. On-state current as a function of on-state voltage



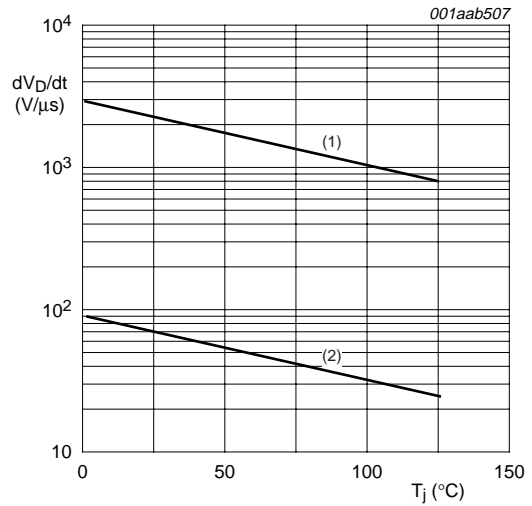
$R_{GK} = 1\text{ k}\Omega$

Fig 10. Normalized latching current as a function of junction temperature



$R_{GK} = 1\text{ k}\Omega$

Fig 11. Normalized holding current as a function of junction temperature



(1) $R_{GK} = 1\text{ k}\Omega$
 (2) Gate open circuit

Fig 12. Critical rate of rise of off-state voltage as a function of junction temperature; typical values

7. Package outline

Plastic single-ended leaded (through hole) package; 3 leads

SOT54

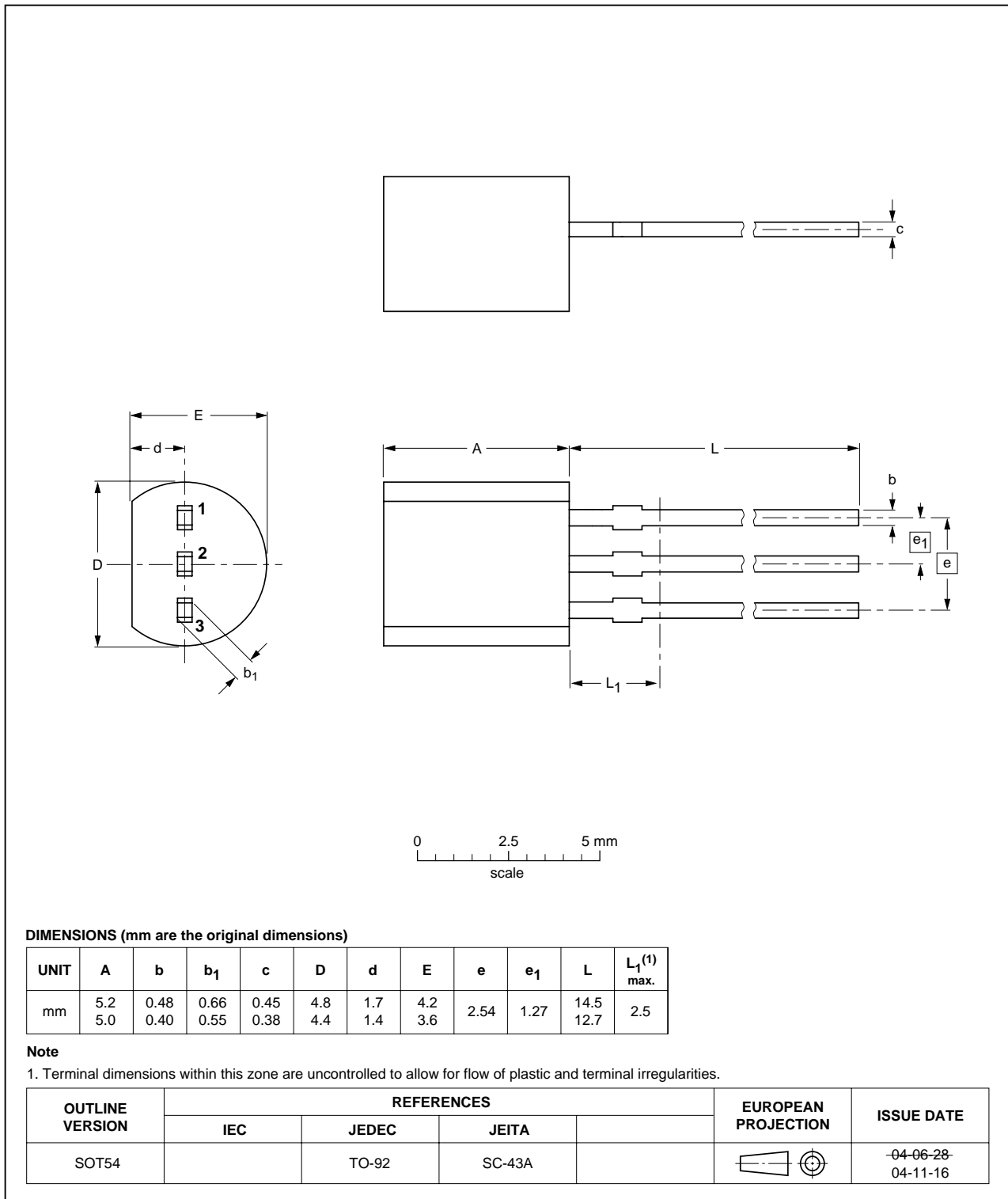


Fig 13. Package outline SOT54 (TO-92)

8. Revision history

Table 6. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
BT169H_1	20080331	Product data sheet	-	-

9. Legal information

9.1 Data sheet status

Document status ^{[1][2]}	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

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